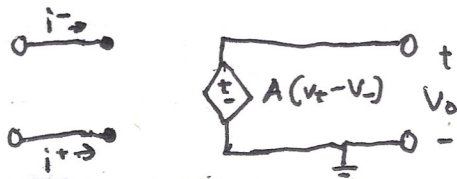
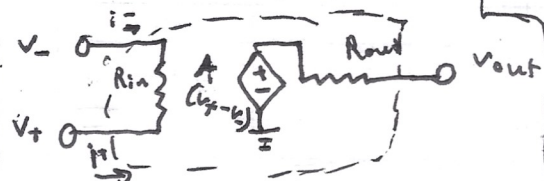
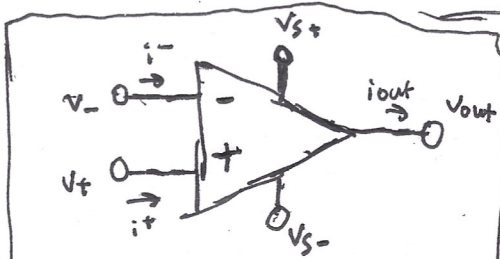
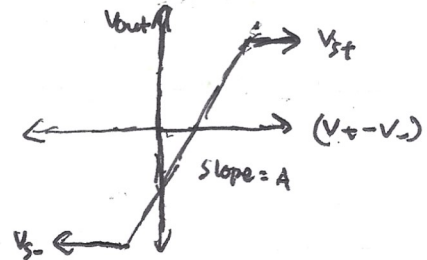


I deal Op-Amp~~Ident Model~~

Typical Parameters

$$A = 10^4 \quad V_{st}/V_{s-} = 10V$$

$$(v_+ - v_-) = \pm 1mV$$



III I II
Neg. Linear Pos.
Saturation Saturation

To maintain linear version,
we use negative feedback.

Ideal Op-Amps :

$$R_i = \infty$$

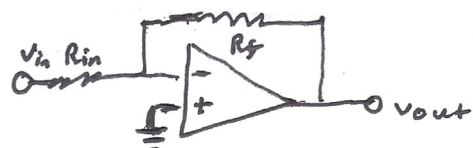
$$A = \infty$$

$$R_o = 0$$

$$i_- = i_+ = 0$$

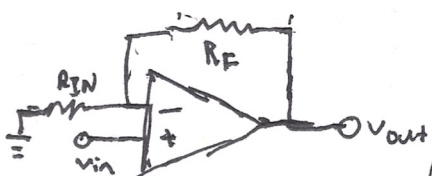
$$v_- = v_+$$

Inverting Amp



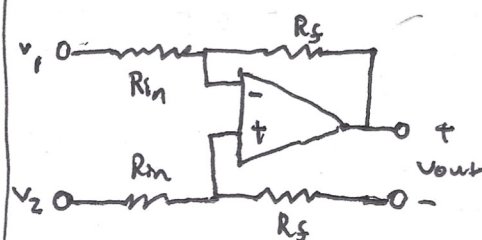
$$v_{out} = -\frac{R_f}{R_{in}} v_{in}$$

Non Inverting Amp

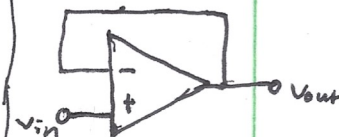


$$v_{out} = \left(1 + \frac{R_f}{R_{in}}\right) v_{in}$$

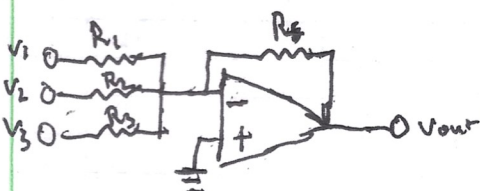
Differential Amp



$$v_{out} = \frac{R_f}{R_{in}} (v_2 - v_1)$$

Voltage follower
(buffer)

Summing Amp



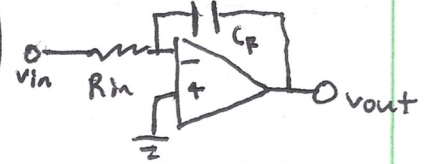
$$v_{out} = -R_f \left(\sum v_i / R_{in} \right)$$

Differentiating Amp



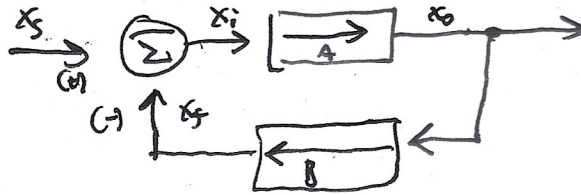
$$v_{out} = -R_f C_{in} \frac{dv_{in}}{dt}$$

Integrating Amp



$$v_{out} = -\frac{1}{R_{in} C_f} \int_0^+ v_{in}(t) dt$$

Feedback Loops



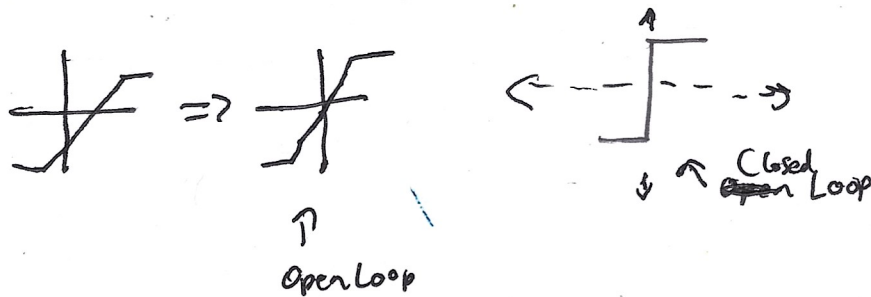
$$x_0 = Ax_i \quad x_f = \beta x_0$$

A = open-loop gain β - feedback factor

$$x_i = x_s - x_f \Rightarrow \text{Closed-loop gain: } A_f = \frac{x_o}{x_s} = \frac{A}{1 + A\beta}$$

$$AB \gg 1 \Rightarrow A_g = \frac{1}{\beta}$$

To use offset correction, a differential amp is used.

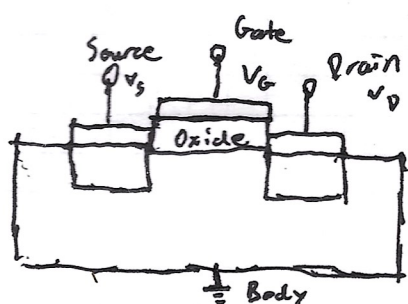


$(V_t - V_-) \ll$	Semi ideal	$V_t - V_- = 0$
$A \approx (10^4)$	$(V_t - V_-) \ll$	$A \rightarrow \infty$
$R_o \ll$	$A \approx (10^4)$	$R_o = 0$
	$R_o = 0$	$i_- = i_+ = 0$
V_{in}	$i_- = i_+ = 0$	

In freq. dep. analysis: replace everything with the impedance.

Field-Effect Transistors

★ Review 2K1 Chpt 13 on basics over n-channel enhancement mode MOSFETs.

Creation of a MOSFET

The wells will be doped and the silicon substrate will be doped oppositely. Source is usually slightly more doped.

- n-doped = excess electrons a.k.a electrons = charge carriers (Usually P_n doped)
- p-doped = excess holes a.k.a holes = charge carriers (Usually B_p doped)
- Some mosfets will have a channel between the two wells with the same doping (depletion mode).

★ A layer of oxide separates the gate and substrate that is insulating, meaning $I_G = 0$ can be assumed.

Symbols	enhancement mode (OFF)	depletion mode (ON)	← (Normal State)
n-channel			
p-channel			

(Arrows indicate direction of conv. current flow).

Ideal MOSFET

$$V_{th} = \text{Threshold Voltage} \Rightarrow \begin{aligned} &n\text{-ch. enh.} + p\text{-ch. dep.} = V_{th} > 0 \\ &p\text{-ch. dep.} + n\text{-ch. enh.} = V_{th} < 0 \end{aligned}$$

To turn on enh. mode MOSFETs, Gate must be polarized opposite to charge carriers (+V_{GS} for n, -V_{GS} for p).

To turn off dep. mode MOSFETs, Gate-Source must be polarized same to charge carriers (-V_{GS} for n, +V_{GS} for p).

(Most of the times body + source are @ same potential). tech. transistors are driven by volt. diff. between Gate + Body.

The Gate operates like a capacitor w/ capacitance rep. as C_{ox}.

Att. ~~enh. mode~~ require

$$\begin{aligned} \text{Cutoff} &= V_{GS} \leq V_{th} \text{ for } n\text{-ch.} \\ &V_{GS} > V_{th} \text{ for } p\text{-ch.} \end{aligned}$$

Ideal MOSFETs cont'd

Triode-Sat. Boundary: $V_{DS(sat)} = V_{GS} - V_{th}$ or $V_{GD} = V_{th}$

* $V_{DS} < V_{DS(sat)} =$ Triode Region

- Complete channel connects source + drain
x Length - L , Cross sec. Area - A
- V_{DS} and I_D are linearly related, the ohmic/linear/triode region of a transistor.
x $R = \frac{PL}{A}$, P depends on channel and charge concentration

* $V_{DS} \geq V_{DS(sat)} =$ Saturation Region

- Channel pulls back from drain making $R \uparrow$.
- V_{DS} will be high enough to allow charge to still flow
- I_D is ideally indep. from V_{DS} .

Ineq. Slipped for p-channels. + Must not be in Cutoff for these regions to be reached.

k_n/k_p - Fixed parameters of a transistor for n/p channel MOSFET.

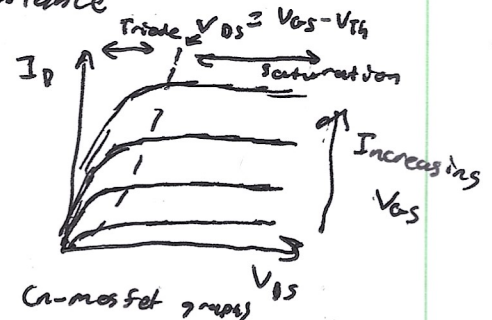
$k_n = \mu C_{ox} \frac{W}{L}$ μ - charge mobility, W/L - width + length of channel
(units $\frac{mA}{V^2}$) (use μ_{min}) C_{ox} - oxide layer capacitance

These are
- when
PMOS

$$I_{D(Triode)} = k_n (V_{GS} - V_{th}) V_{DS} - \frac{V_{DS}^2}{2}$$

$$I_{D(Saturation)} = k_n \frac{(V_{GS} - V_{th})^2}{2} = k_n \frac{V_{DS(sat)}^2}{2}$$

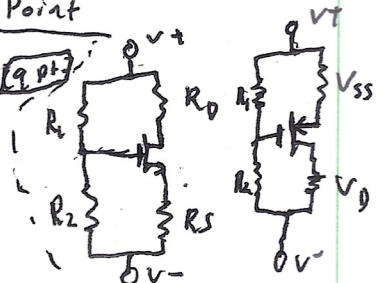
$$I_{D(Cutoff)} = 0$$

Solving

1. I_D V_{GS} + V_{DS} (Control Voltages)
2. Use KVL, writing I_D as a func. of Control Voltages
3. Assume Saturation first.
4. Utilize $I_G = 0$ for KVL.

Designing Op. Point

To obtain operating pt. of V_{DS} , I_D w/ 4 resistors $\rightarrow$ we want this point

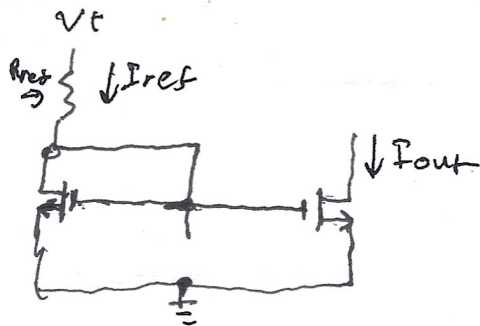


to be at $(\frac{1}{2} V_{DS(max)}, \frac{1}{2} I_{D(max)})$ or the mid. of each

the load line. Then Derive V_{GS} and use KVL to find V_G . $I_G = 0$ so use R_1 + R_2 for voltage divider to set V_G . R_1 + R_2 should both be big so $\downarrow$ power is dissipated.

$$I_{D(max)} = \frac{V^+ - V^-}{R_D + R_{SS}} \quad - A \text{ sho}$$

$$V_{DS(max)} = V^+ - V^- \quad - A. I =$$

Indep. Current Source

$$M_1 = M_2$$

$$I_{out} = I_{res}$$

Changing R_{res} will change I_{res}/I_{out}
w/ diff channel parameters

$$(k_{n2} \neq k_{n1}) \Rightarrow I_{out} = \alpha I_{REF}$$

Channel Length Modulation

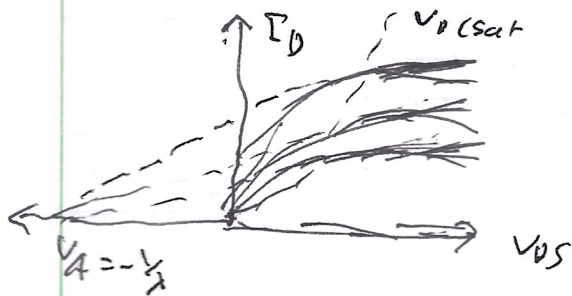
- Non-ideality of drain current: $I_{D(sat)}$ is not truly indep. of V_{DS} . As V_{DS} continues to increase past $V_{DS(sat)} = V_{GS} - V_{th}$, the channel will draw back further from the drain.

$$I_{D(sat)} = \frac{1}{2} k_n (V_G - V_{th})^2 (1 + \lambda (V_{DS} - V_{DS(sat)}))$$

$$= \frac{1}{2} k_n V_{D(sat)}^2 (1 + \lambda (V_{DS} - V_{DS(sat)}))$$

where λ is the chm. parameter

$I_D - V_{DS}$ graph



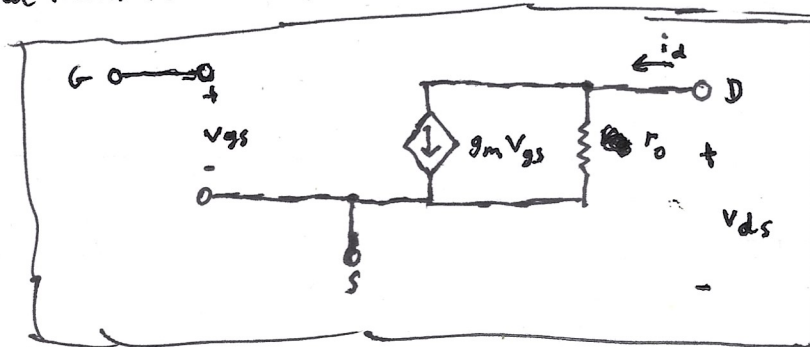
Extrapolating the saturation current lines backward should cause them to intersect @ $I_D = 0$,
 $V = -\frac{1}{\lambda} = V_A$ (Early Voltage)

This results in an output resistance we need to account for.

FET Small-Signal Model

- Mid-Frequency

- This model is useful for most frequencies, aka the mid-frequency model.
- It's useful for modeling MOSFETs with AC voltage + currents.
- AC model components are highly dependent on DC op. pt.
- we need to compute g_m and r_o to characterize this model and transistor amplifier circuits.



$r_o \approx \infty$ / open
if no chn is
present.

Trans conductance - g_m

$$g_m = \frac{i_d}{v_{gs}} = \frac{\partial I_D}{\partial V_{GS}}$$

$\Rightarrow$

$$g_m = k_n (V_{GS} - V_{TH}) = \sqrt{2k_n I_D} \quad \star$$

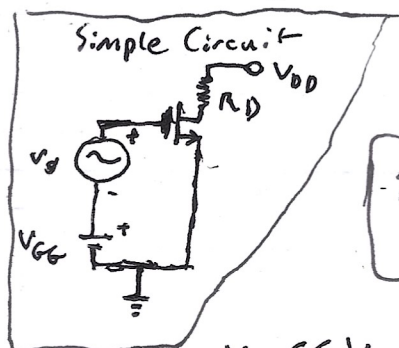
unit $\frac{A}{V}$

(I_D is DC current)

This is derived assuming $V_{GS} = V_{GS} + v_{gs} \approx V_{GS}$
The same assumption is used for current.

i_d has a transconductance that varies with $\sqrt{I_D}$ - DC quiescent current.

Using the load line mentioned before, AC input will move back & forth from open-circuit voltage ($V_{oc} = V_{DD}$) and the short-circuit current (here, $I_{sc} = \frac{V_{DD}}{R_D}$).



$i_D = I_D + i_d$

$$i_d = k_n (V_{GS} - V_{TH}) v_{gs} + \frac{1}{2} k_n v_{gs}^2$$

$$\begin{aligned} i_D &= \frac{1}{2} k_n (V_{GS} - V_{TH})^2 \\ &= \frac{1}{2} k_n (V_{GS} - V_{TH})^2 + k_n (V_{GS} - V_{TH}) v_{gs} + \frac{1}{2} k_n v_{gs}^2 \\ &= I_D + i_d \end{aligned}$$

$v_{gs} \ll V_{GS} - V_{TH}$ for small signal models + maintains linear model.
($v_{gs} \leq 0.2(V_{GS} - V_{TH})$)

$$\Rightarrow i_d \approx k_n (V_{GS} - V_{TH}) v_{gs}$$

(Chn) $\Rightarrow (1 + \lambda(V_{DS} - V_{DS(sat)})) \neq \lambda(V_{DS} - V_{GS})$
Param
for
AC

$$r_o = \frac{\partial V_{DS}}{\partial I_D} = \frac{1}{\lambda I_D}$$

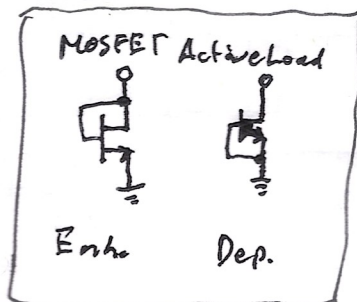
Output Resistance - r_o Internal Output Res. $\downarrow$ w/ $\uparrow I_D$ (DC curr)MOSFETs as Active Loads

Replacing a Resistor with a transistor to reduce DC voltage drop with a high small signal AC Impedance.

Slope of I-V = Inverse of AC resistance $\lambda \downarrow = r_o \uparrow$

Mos + MOSFETs $r_o = 10-100s\ k\Omega$ sometimes larger too.

This means small variations in output voltage shouldn't affect output current. Smaller I-V slope = larger V_{DS} swings allowed before large i_D . Large i_D increases chance that we move to edges of the load line, either $\uparrow$ near $i_D = 0$ = triode region or $\downarrow$ min $i_D = 0$ = cutoff region.



$\Rightarrow$ This setup ensures MOSFETs don't reach cutoff.

This also means $I_D = 0 \Rightarrow V_{DS} = 0$

This implies $V_{GS} = 0$ at all times from the dep. mode model, meaning it will act like a

resistor of $r_o \Omega$ in mid-freq. small signal models.

This is bc. the curr. source model will result in 0 curr. only leaving the resistor.

AC Analysis

1. Replace coupling & bypass capacitors w/ shorts.
2. All DC sources = 0
3. Replace MOSFET w/ small signal equiv.

Amplifier Circuits

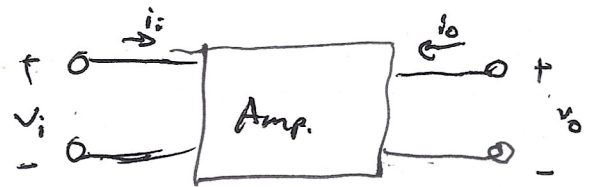
Black box interpretations:

$$A_{vi} = \frac{V_o}{V_i}$$

$$A_i = \frac{i_o}{i_i}$$

$$R_{is} = \frac{V_i}{i_i} \big|_{V_o=0}$$

$$R_{os} = \frac{V_o}{i_o} \big|_{V_i=0}$$

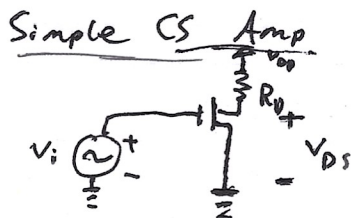


Dep Source Model



Intrinsic V gain of a MOSFET

$$M_g = g_m r_o = \frac{1}{\lambda} \sqrt{\frac{2k_n}{I_D(\text{sat})}}$$

Common Source Amp

To ensure Q-point stability we will use coupling capacitors (to AC w/o changes DC bias) and bypass capacitors (for AC curr to set around resistors)

To solve for Amps.:

Separate into DC + AC circuits.

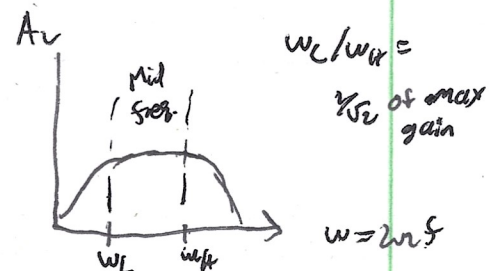
DC Circuit:

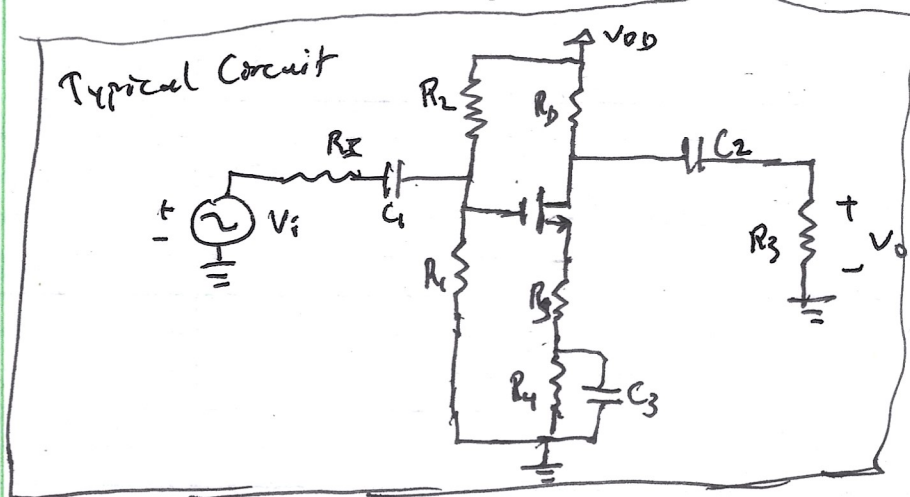
1. Capacitors = open
2. Inductors = short
3. Deactivate AC Sources

Find Q-Point:

AC Circuit:

1. Capacitors = Short (@ op freq.)
2. Inductors = Open (@ op freq.)
3. DC V Sources = Deactivate/Short
4. DC I Sources = Deactivate/Open
5. Transistor $\Rightarrow$ Small Signal Model
6. Analyze AC Response

When $A_v \ll \beta g_s$, we can ignore r_o .You can calc A_v from $\frac{V_o}{V_i}$ and $\frac{V_o}{V_g}$ 

Common Source Amp ContdInverting
Amp

$$A_v = -\frac{g_m R_L}{1 + g_m R_S} \left(\frac{R_G}{R_I + R_G} \right) \quad R_{in} = \infty, R_{out} = R_L$$

where $R_L = E_g R_{es}$ From Drain to Ground in AC

and $R_G = E_g R_{es}$ From Gate to Ground in AC

To Calc R_L , use R_{eq} from AC model ~~Turn off independent sources~~ (remove other C_s)

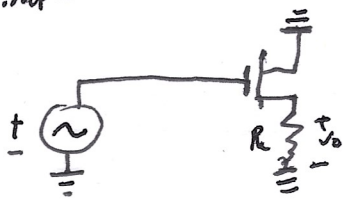
$$w_c = \frac{1}{(R_I + R_1 \parallel R_2) C_1}, \quad w_c = \frac{1}{(R_D + R_3) C_2}, \quad w_c = \frac{1}{\left(\frac{1}{g_m} \parallel R_{SS}\right) C_3}$$

$$w_c = \max(w_{c1}, w_{c2}, w_{c3})$$

w units - rad/s

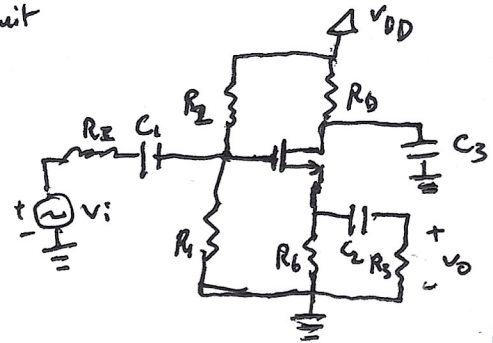
Common Drain Amp

Simple Circuit



Follower Circuit

Typical Circuit



$$A_v = \frac{g_m R_L}{1 + g_m R_L} \left(\frac{R_G}{R_I + R_G} \right) \approx \frac{R_G}{R_I + R_G} \quad R_{in} = \infty$$

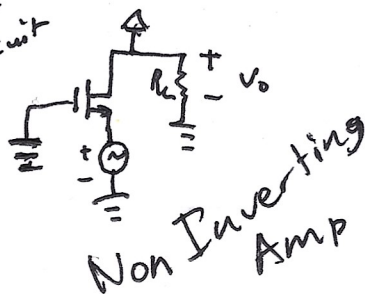
$$R_{out} = \frac{1}{g_m}$$

$$\omega_{c1} = \frac{1}{R_I + R_I \parallel R_2}, \quad \omega_{c2} = \frac{1}{(R_S + R_S \parallel \frac{1}{g_m}) C_2}$$

$$\omega_L = \max(\omega_{c1}, \omega_{c2})$$

(C₃/R_D Not always included)Common Gate Amp

Simple Circuit

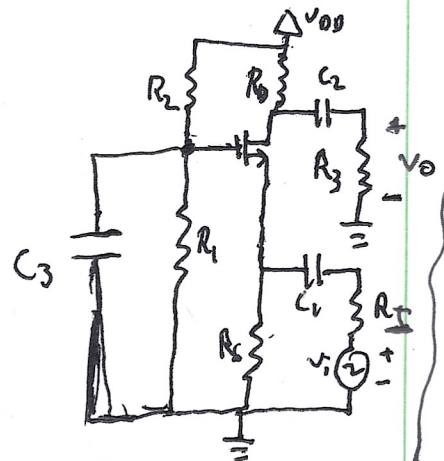


Non Inverting Amp

$$A_v = \frac{g_m R_L}{1 + g_m (R_I \parallel R_G)} \left(\frac{R_G}{R_I + R_G} \right)$$

$$R_{in} = \frac{1}{g_m} \quad R_{out} = R_L$$

Typical Circuit

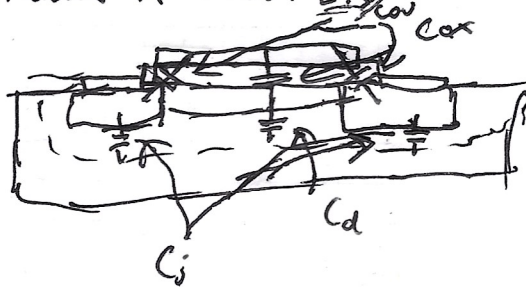


$$\omega_{c1} = \frac{1}{(R_I + R_I \parallel (\frac{1}{g_m})) C_1}, \quad \omega_{c2} = \frac{1}{(R_D + R_D \parallel R_2) C_2}, \quad \omega_{c3} = \frac{1}{R_I \parallel R_2 C_3}$$

$$\omega_L = \max(\omega_{c1}, \omega_{c2}, \omega_{c3})$$

High Freq. cutoff

Capacitances in MOSFETs



Intrinsic Capacitances

 C_{ox} - Oxide Capacitance C_d - Depletion capacitance

Parasitic Capacitances

 C_i - Junction Capacitance C_{ov} - Overlap Capacitance

$$C_{ox} = C_{gs} + C_{gd}$$

 w_H is defined by C_{gs} and C_{gd} .

Gate to Channel Capacitance:

$$C_{gs}(F) = WL C_{ox}$$

$$C_{gs} = \frac{2}{3} C_{gc} + C_{gso} X_{so}$$

$$C_{gd} = C_{gdo} X_{do}$$

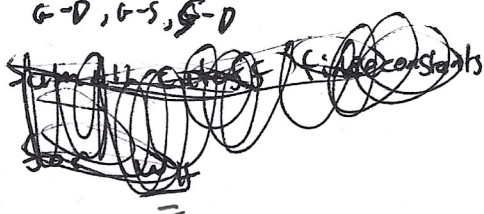
 C_{gso} - Cap of oxide + source overlap C_{gdo} - Cap of oxide + drain overlap X_{so} - len of oxide on source X_{do} - len of oxide on drain C_{gs} will connect gate + source in AC model.

$$R_{wH} = \frac{1}{R_{gs} C_{gs}}$$

C_{gs} can be replaced w/ any parallel capacitance to the curr. source.

aka Capacitance connecting

G-D, G-S, G-D

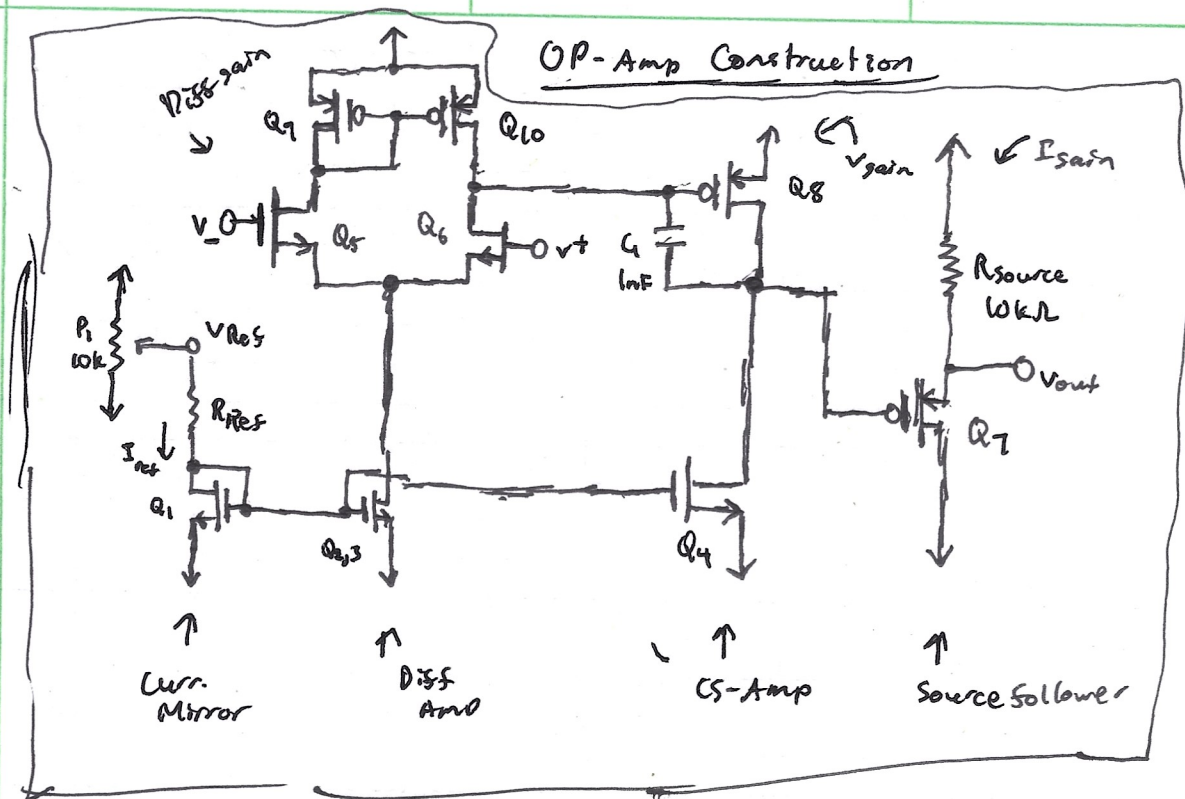


Max Linear Freq (Indep of System)
Based on MOSFET

$$f_T = \frac{1}{2\pi} \frac{g_m}{C_{gc}} = \frac{1}{2\pi} \frac{\mu}{L^2} (V_{gs} - V_T)$$

M - Channel Mob. L - Channel Len.

sum $C_{gs} + C_{gd}$ in denom
and take min vs C_{gs}/C_L freq.



ODEs for RL+RC circuits

(Series)

First order Circuits:

• RL Circuit: $V_L = L \frac{di_L(t)}{dt} \Rightarrow v_{in}(t) = L \frac{di_L(t)}{dt} + Ri_L(t)$

(Derived from KVL)

• RC Circuit: $V_C = C \frac{dv_C(t)}{dt} \Rightarrow v_{in}(t) = RC \frac{dv_C(t)}{dt} + v_C(t)$

- Use KVL or KCL to determine relations and find homogenous + particular solutions, use conditions to solve for A+B + add them together. Then plug the variable value in

the inductor/capacitor voltage equation.

- λ reps the natural frequencies.

ODEs for LC Circuits
Second Order circuits(Euler's: $e^{j\theta} = \cos(\theta) + j\sin(\theta)$)

• LC Circuit: $V_L = L \frac{di_L(t)}{dt}$ $i_C = C \frac{dv_C(t)}{dt} \Rightarrow v_C(t) = LC \frac{d^2 v_C(t)}{dt^2}$

- Use same strat as before

ODEs for RLC Circuits

• RLC Circuit: $v_{in}(t) = RC \frac{dv_C(t)}{dt} + LC \frac{d^2 v_C(t)}{dt^2} + v_C(t)$

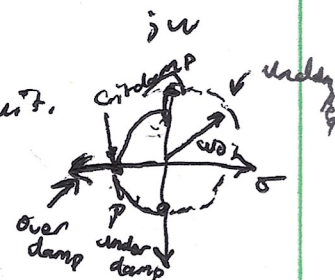
or $\frac{dv_{in}(t)}{dt} = R \frac{di_L(t)}{dt} + L \frac{d^2 i_L(t)}{dt^2} + \frac{1}{C} i_L(t)$

- Damping is done by adding resistors to an LC circuit.

- Over damping = Frequencies are real + distinct

- Critically damped = Frequencies are real + equal

- Under damping = Frequencies are complex

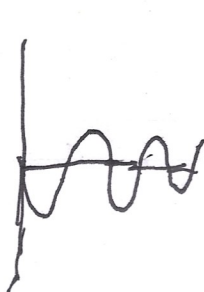


Undamped:

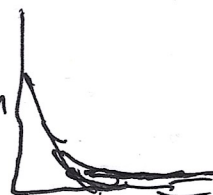
Under damped

Critically damped

Over damped



where σ_p is the attenuation factor and ω is the damped res freq.



Roots: $-\sigma_p \pm j\omega_d$ Particular gives center of oscillation

$$\omega_0 = \frac{1}{\sqrt{LC}}$$

$$\omega_d = \sqrt{\omega_0^2 - \sigma_p^2}$$

Switched Circuits

We know RL & RC circuits gen sol. $\Rightarrow x(t) = x(\infty) + [x(t_0^+) - x(\infty)] e^{-\frac{(t-t_0)}{\tau}}$

$\tau = RC$ or $\frac{L}{R}$ where $x(t)$ can be i_L or V_C

Given $x(t_1) = x_1$ $x(t_2) = x_2$ we can find the time between two states:

$$t_2 - t_1 = \tau \ln \left[\frac{x_1 - x(\infty)}{x_2 - x(\infty)} \right]$$

• Steps:

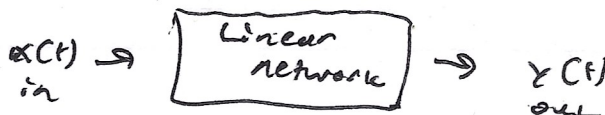
- Determine $t_1 \leq t \leq t_2$ (time range)
- Find $x(0)$, $x(\infty)$, R_{Th} , τ , voltages at t_1 & t_2 .
- Plug into solution, plug ~~solution~~ values into time equation to find $t_2 - t_1$!

Function Transform

- Unit Step Function: $u(t) = \begin{cases} 0 & t < 0 \\ 1 & t \geq 0 \end{cases}$
- Rectangular Function: $c(t) = \begin{cases} 0 & t < t_1 \\ 1 & t_1 \leq t < t_2 \\ 0 & t \geq t_2 \end{cases} = u(t-t_1) - u(t-t_2)$
- Unit Impulse Dirac Function: $\delta(x) = \begin{cases} \infty & x=0 \\ 0 & x \neq 0 \end{cases}$
 $\int_{-\infty}^{\infty} \delta(\tau) d\tau = 1$ $\int \frac{d}{dt} u(t) = \delta(t)$

Convolution

- ODE methods are tedious for large circuits, so use convolution
- Convolution relates inputs (excitations) to ~~net~~ outputs (responses) using a circuit model operated on by the input functions to get the out



- Convolution of $f(t) * g(t) = \int_{-\infty}^{\infty} f(\tau) g(t-\tau) d\tau$ or (for a time period) $= \int_0^t f(\tau) g(t-\tau) d\tau$ (shown below)
 moving g reflected across y across the graph. area of intersection is $f(t) * g(t)$

• $x(t) * \delta(t) = x(t) \Rightarrow x(t) * \delta(t) = \int_{t_0}^{t_0} x(\tau) \delta(t_0 - \tau) d\tau = x(t_0)$

Use when function is shifted T

• Time shifting: $x(t) * \delta(t-T) = \int_{t_0-T}^{t_0} x(\tau) \delta(t_0 - (\tau-T)) d\tau = x(t-T)$

• $y(t) = x(t) u(t) * u(t) = \int_{-\infty}^{\infty} x(\tau) u(t-\tau) d\tau$
 $x(t) u(t) * u(t) = \int_0^t x(\tau) d\tau u(t)$

• Alg props:

$$f(t) * g(t) = g(t) * f(t)$$

$$[f(t) * g(t)] * h(t) = f(t) * [g(t) * h(t)]$$

$$f(t) * [g(t) * h(t)] = f(t) * g(t) + f(t) * h(t)$$

- converting time domain set it so unit step is where the top bound = bottom bound.

Time shifting Simple:

$$x(t) * \delta(t-T) = x(t-T)$$

Discrete Convolution

$$u[n] = \begin{cases} 0 & n < 0 \\ 1 & n \geq 0 \end{cases} \quad \delta[n] = \begin{cases} 0, & n \neq 0 \\ 1, & n = 0 \end{cases} \quad \text{where } n \in \mathbb{Z}$$

$$f[n] * g[n] = \sum_{m=-\infty}^{\infty} f[m] g[n-m]$$

- Uses same graphical shift as regular conv.
- Same alg. properties as reg. conv.
- Convert complex sums into discrete



Max spacing = 0.2 (FWHM)

Preferred = 0.1 (FWHM)

where FWHM is width at 50% amp.

Preferred extension of peak tails = 2.0 (FWHM)

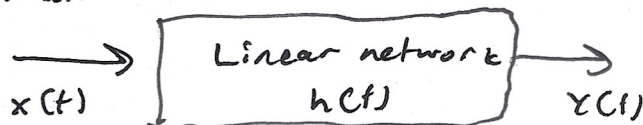
↑ Accuracy with ↓ time intervals.

Impulse Response

• Linear Time Invariant Systems (LTIS)

- produce output signals related to inputs linearly & time invariantly

- Diagram:



or $y(t) = x(t) * h(t)$

→ Using $x(t) = \delta(t)$, we can find $h(t)$.

* $y(t) = \delta(t) * h(t) = h(t)$

* $h(t)$ is the Impulse Response

• The ODEs for RLC circuits give us the step response.

- To find impulse response from step response, take the derivative of the step response.

- $v_{in} = u(t)$ to find step response.

or $i_{in} = u(t)$

Laplace Transformations

- Transforms from time domain to frequency domain (Discrete)
 - Reciprocal of time is frequency. can solve in freq and convert back
- One sided Laplace Transform:

$$\mathcal{L}\{f(t)\} = F(s) = \int_0^{\infty} f(t) e^{-st} dt$$

where s is the complex frequency. $s = \sigma + j\omega$

- Laplace Transforms of functions:

$$\mathcal{L}\{\delta(t)\} = 1$$

$$\mathcal{L}\{\delta(t-t_0)\} = e^{-s t_0}$$

$$\mathcal{L}\{u(t)\} = \frac{1}{s} \leftarrow s > 0$$

- Properties

$$\mathcal{L}\left\{\frac{d}{dt} f(t)\right\} = sF(s) - f(0^-)$$

$$\mathcal{L}\left\{\frac{d^2}{dt^2} f(t)\right\} = s^2 F(s) - s f(0^-) - \frac{df(0^-)}{dt}$$

$$\mathcal{L}\left\{\int_{-\infty}^+ f(\tau) d\tau\right\} = \frac{F(s)}{s} + \frac{\int_{-\infty}^0 f(\tau) d\tau}{s}$$

$$\mathcal{L}\{af(t) + b g(t)\} = aF(s) + bG(s)$$

$$\mathcal{L}\{f(t-t_0)\} = e^{-s t_0} F(s) \leftarrow \text{Time shift}$$

$$\mathcal{L}\{e^{-at} f(t)\} = F(s+a) \leftarrow \text{Freq. shift}$$

$$\mathcal{L}\{f(t) * g(t)\} = F(s) G(s)$$

$$\mathcal{L}\{t^n f(t)\} = (-1)^n \frac{d^n}{ds^n} F(s)$$

- Use PFD to decompose fractions for inverse LT.
- Actual formula rarely used:

$$\frac{1}{j2\pi} \oint_{\Gamma} F(s) e^{st} ds$$

- Final Value Theorem

$$\lim_{t \rightarrow \infty} f(t) = f(\infty) = \lim_{s \rightarrow 0} s F(s)$$

Remember
Upper Case
is
replaced

Current - Voltage Rels.
in s-domain (freq. domain)

- Regular Response is applicable for any time
- Zero-State Response is when initial cond. are zero.

	Reg Resp.	Zero-State
Resistors		
$V_R(s)$	$R I_R(s)$	$R I_R(s)$
$I_R(s)$	$G V_R(s)$	$G V_R(s)$
Inductors		
$V_L(s)$	$L (s I_L(s) - i_L(0))$	$s L I_L(s)$
$I_L(s)$	$\frac{1}{L} \left(\frac{V_L(s)}{s} + \frac{\int_{-\infty}^0 V_L(\tau) d\tau}{s} \right)$	$\frac{1}{sL} V_L(s)$
Capacitors		
$V_C(s)$	$\frac{1}{C} \left(\frac{I_C(s)}{s} + \frac{\int_{-\infty}^0 i_C(\tau) d\tau}{s} \right)$	$\frac{1}{sC} I_C(s)$
$I_C(s)$	$C (s V_C(s) - v_C(0))$	$s C V_C(s)$

- Impedance can be defined as $Z(s) = \frac{V(s)}{I(s)}$. Admittance is $Y(s) = \frac{1}{Z(s)}$
- This means: and Admittance:

$$\begin{aligned} Z_R &= R \\ Z_L &= sL \\ Z_C &= \frac{1}{sC} \end{aligned}$$

$$\begin{aligned} Y_R &= G \\ Y_L &= \frac{1}{sL} \\ Y_C &= sC \end{aligned}$$

- We can do this to solve odes. Use Impedances to find V/I in s-domain, and use inverse Laplace to get the time domain equations.

Initial Conditions

- Capacitor initial conditions.

$$I_C(s) = C(sV_C(s) - v_C(0^-))$$

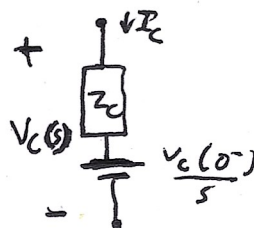
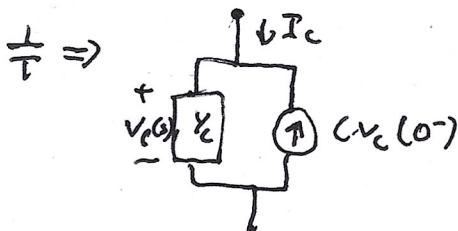
or

$$V_C(s) = I_C(s)Z_C(s) + \frac{v_C(0^-)}{s}$$

$$Y_C = sC$$

$$\Downarrow I_C(s) = V_C(s)Y_C(s) - (v_C(0^-))$$

$$Z_C = \frac{1}{sC}$$



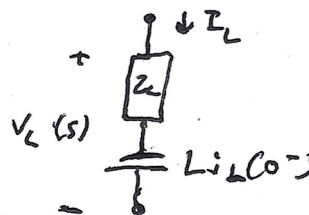
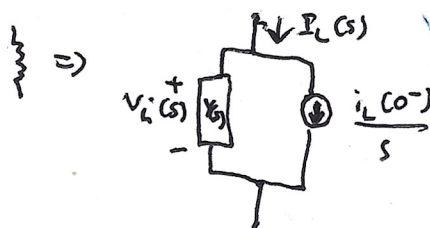
- Inductor initial conditions

$$I_L(s) = V_L(s)Y_L(s) + \frac{i_L(0^-)}{s}$$

or

$$V_L(s) = I_L(s)Z_L(s) - Li_L(0^-)$$

$$Y_L = \frac{1}{sL}$$



- Use series model when circuit is series and parallel model when circuit is parallel.

- Use superposition to calculate voltages across internal impedances (calc with source and with init. cond. separately). Then use initial condition to find properties across the component.

- Complete Response = Zero-Input Resp. (ZIR) + Zero-State Resp. (ZSR)

- ZIR - Response to init cond. + turning off all inputs.

- ZSR - Response to input sig. + turning off all init. cond.

- Forced Resp. - Resp. from components not assoc. w/ natural freq (aka roots of char. eq.)

- Natural Resp. - Resp. from components assoc. w/ natural freq

- Transient Resp. - Resp. that changes w/ time (No sinusoidal/constant)

- Sinusoidal Steady State Resp. - Resp. that is sinusoidal w/ time

Transfer Function

- From $y(t) = h(t) * x(t) \Rightarrow Y(s) = H(s)X(s)$
 Out $\uparrow$ In $\uparrow$
- Depends on the question, voltage & current vars can be assigned to $Y(s)$ or $X(s)$. We find $H(s)$ by finding $Y(s)$ when $X(s) = 1$ and using $H(s) = \frac{Y(s)}{X(s)} \xrightarrow{X(s)=1} H(s) = Y(s)$.
 - Initial conds = 0 (No stored energy)
 - No Indep. Sources.

The Complexity Plane + Stability

- Imped. & Admit. & Transfer Functions are rational functions:

$$H(s) = \frac{P(s)}{Q(s)} = \frac{a_0 + a_1s + a_2s^2 + \dots + a_ms^m}{b_0 + b_1s + b_2s^2 + \dots + b_ns^n} \quad (m \leq n)$$

$$H(s) = K \frac{(s-z_1)^{q_1} (s-z_2)^{q_2} \dots (s-z_m)^{q_m}}{(s-p_1)^{r_1} (s-p_2)^{r_2} \dots (s-p_n)^{r_n}}$$

p_n are the poles of $H(s)$, r_n is order of repeated poles
 z_n are the zeroes of $H(s)$, q_m is order of repeated zeroes
 K is the gain constant

- Once $H(s)$ is found, response to any input can be calcd (if the in var is the same)
- Trans. Func. shows info of system through its form.
- Freq. Resp $s = j\omega$ or $s = \sigma + j\omega$ (remember $\omega_0 = \frac{1}{\sqrt{LC}}$ Radius)
 (the damping circle.)
- X - pole, • - zeroes
- Poles show nat. response, $H(s)$ inverse laplace is nat. response
 - order of pole > 1 , multiply term by t (~~sub for and solve for t~~)

Circuit cond. finite
 $a, s \rightarrow \infty$

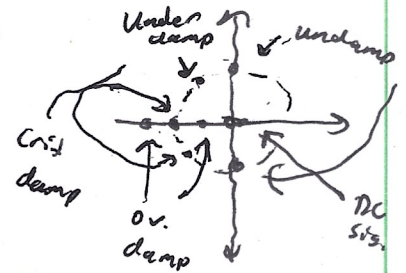
- When doing inverse laplace, we can tell stability.
 - If order of pole > 1 ($A t^{k-1} u(t)$), unstable, else ($A u(t)$) stable. ($\frac{A}{s}$ or $\frac{A}{s^k}$)
 - $p_i > 0$ = unstable, $p_i < 0$ = stable ($\frac{A}{s-p_i}$)
 - $p_i < 0$ = stable ($\frac{A}{(s-p_i)k}$)
 - Marginally stable ($\frac{A(s)+B}{(s^2+\omega^2)}$)
 - $a > 0$ = stable, $a < 0$ = unstable ($\frac{A(s)+B}{(s^2+a^2+\omega^2)}$)

The Complexity Plane + Stability contd

• Bounded input, bounded output Stability (BIBO)

- Sols have to be bounded for stability

Means $\left\{ \begin{array}{l} - \text{In: } \int_{-\infty}^{\infty} |x(t)| dt < K_I < \infty \\ - \text{Out: } \int_{-\infty}^{\infty} |y(t)| dt < K_O < \infty \end{array} \right.$ $\leftarrow$ Max vals



• Bibo is assured if all poles $\sigma_i < 0$ (left) stability

• ~~Not~~ unstable if any pole $\sigma_i > 0$

• Order 1 poles + $\sigma_i = 0$ are marg. stable

• Order 2 poles + $\sigma_i = 0$ are unstable

• Zeroes show where the output will only be natural resp, not natural + forced.

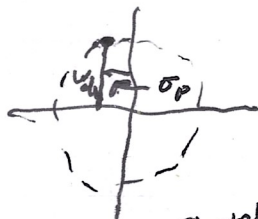
Resonance

- RLC circuit is in resonance when the voltage and current are in phase at the input terminals.

- σ_p is exp. attenuation factor (real part)

- ω_d is damped res. freq. (im. part)

$$\omega_0 = \sqrt{\omega_d^2 + \sigma_p^2} = \frac{1}{\sqrt{LC}}$$



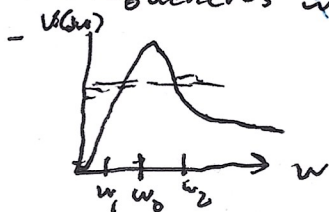
- Phasor method: replace $s = j\omega$

• ω_r is freq. when im/pt adm. becomes purely real. Resonance frequency

(where) - $\omega_r = \omega_0$ IN SIMPLE CIRCUITS

- Max Voltage is prop. to resistance, all curr. & flow through resistor.

- Bandwidth $\Rightarrow B_w = \omega_2 - \omega_1$ where ω_2 and ω_1 are frequencies where $volt = \max V \cdot \frac{1}{\sqrt{2}}$



- Phase angle: $\phi = \tan^{-1} \frac{\omega}{\sigma}$ $\leftarrow \sigma + j\omega$

- To convert an algebraic phasor into phasor form do this $\sigma + j\omega \Rightarrow \sqrt{\sigma^2 + \omega^2} \angle \tan^{-1}(\frac{\omega}{\sigma})$

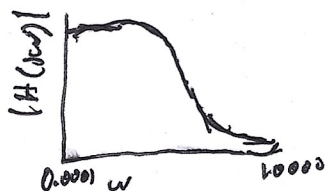
- ex. $Z(j\omega) \Rightarrow |Z(j\omega)| \angle \tan^{-1}(\frac{\omega}{\sigma}) \Rightarrow |Z(j\omega)| \angle \phi$

- We can graph changes in the phasor while changing ω . There are two graphs, $|Z(j\omega)|$ vs ω and ϕ vs ω which sets us. phasor from frequency.

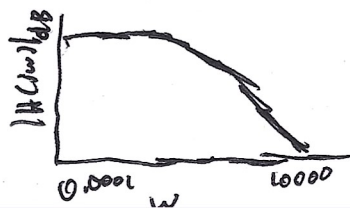
- Bode Plots approx. mag plots:

$$|H(j\omega)|_{dB} = 20 \log_{10} |H(j\omega)|$$

- $\omega = 2 \text{ rad/s}$ is cutoff/half-power freq. between low freq. & high freq.



$\Rightarrow$



Filter Basics



High pass filters
- Allows $\uparrow$ freg.



Low pass filters
- Allows $\downarrow$ freg.

- $|H(j\omega)|_{dB} > 0$ = Amplification, < 0 = Attenuation.
- $(s+z) \Rightarrow (s+\omega_p)$ where ω_p is ang. freg. at pole
- Convention is $(s+z) \Rightarrow 2(\frac{s}{\omega_z} + 1) \Rightarrow 2(\frac{s}{\omega_p} + 1)$

Bode Plots

$$|H(s)| = s = \omega \Rightarrow |H(j\omega)|_{dB} = 20 \log(\omega)$$

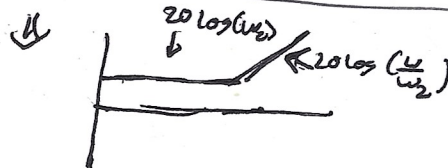
$$|H(s)| = \frac{1}{s} = \frac{1}{\omega} \Rightarrow |H(j\omega)|_{dB} = -20 \log(\omega)$$



$$H(s) = (s+z) \Rightarrow H(j\omega) = \omega_z (1 + \frac{j\omega}{\omega_z})$$

$$\Rightarrow |H(j\omega)|_{dB} = 20 \log(\omega_z) \quad \omega \rightarrow 0$$

$$|H(j\omega)|_{dB} = 20 \log(\omega_z) + 20 \log(\frac{\omega}{\omega_z}) \quad \omega \rightarrow \infty$$



$$H(s) = \frac{1}{s+p} \Rightarrow |H(j\omega)|_{dB} = -20 \log(\omega_p) - 20 \log[\sqrt{1 + \frac{\omega^2}{\omega_p^2}}]$$

$$|H(j\omega)|_{dB} = -20 \log(\omega_p) \quad \omega \rightarrow 0$$

$$|H(j\omega)|_{dB} = -20 \log(\omega_p) + 20 \log(\frac{\omega}{\omega_p}) \quad \omega \rightarrow \infty$$



Bode plots

$$H(s) = K \frac{(s-z_1)(s-z_2)\dots(s-z_m)}{(s-p_1)(s-p_2)\dots(s-p_n)} \Rightarrow H(j\omega) = K \frac{(j\omega-z_1)(j\omega-z_2)\dots(j\omega-z_m)}{(j\omega-p_1)(j\omega-p_2)\dots(j\omega-p_n)}$$

↓

$$|H(j\omega)| = K \frac{\prod_{k=1}^m |j\omega - z_k|}{\prod_{l=1}^n |j\omega - p_l|}, \quad \angle H(j\omega) = \sum_{k=1}^m \angle(j\omega - z_k) - \sum_{l=1}^n \angle(j\omega - p_l)$$

Chpt 28

Magnitude & Frequency Scaling

- Multiply Impedance by K_m (divide C by K_m , multiply R/L by K_m)
- Includes curr. controlled sources
- Divide by K_m for voltage controlled sources

← Mag Scaling

- This results in no change in zeroes or poles
 - $|H|$ could change.

- H has no change for dimensionless H (simple $\frac{z_o}{z_i}$)

- Resistors are not freq. scaled

- $L_{\text{new}} = \frac{L_{\text{old}}}{K_f}$

- $H(s)_{\text{new}} = H\left(\frac{s}{K_f}\right)$

- $C_{\text{new}} = \frac{C_{\text{old}}}{K_f}$

- $K_f > 1$ ↑ peak width, $K_f < 1$ ↓ peak width

↑ Freq. scaling.

Bandpass Response

• Voltage Response Properties.

- Max V is prop. to resistance

$$* Z_{in}(j\omega) = R @ \omega = \omega_r$$

- All current flows through $R @ \omega = \omega_r$

- Width of ^{voltage} response depends on R, L, C

↑ = narrow
↓ = wide

Sharpness
of
peak

* Quality Factor $\Rightarrow$

$$Q = \frac{\omega_m}{B_w} = \frac{\omega_r}{B_w}$$

* Bandwidth $B_w = \omega_H - \omega_L$

- H_m - max of transfer func, ω_m - when $|H(j\omega)| = H_m$

$$\begin{aligned} \omega_H &= \sqrt{\left(\frac{1}{2RC}\right)^2 - \frac{1}{LC}} + \frac{1}{2RC} & \omega_H &= \omega_m + \frac{B_w}{2} \\ \omega_L &= \sqrt{\left(\frac{1}{2RC}\right)^2 - \frac{1}{LC}} - \frac{1}{2RC} & \omega_L &= \omega_m - \frac{B_w}{2} \end{aligned}$$

$$B_w \approx \omega_H - \omega_L = \frac{1}{RC}$$

$$Q = \frac{\omega_m}{B_w} = \omega_0 RC$$

$$H_m = R$$

Specific to parallel

$$B_w = \frac{R}{L}$$

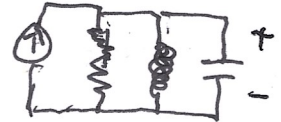
$$Q = \omega_0 \frac{L}{R}$$

Specific to series

$$H_m = \frac{1}{R}$$

$$\omega_H = \omega_m + \frac{B_w}{2}$$

$$\omega_L = \omega_m - \frac{B_w}{2}$$



Passive Low Pass Filters

- Higher order = steeper cutoff.
- First order:

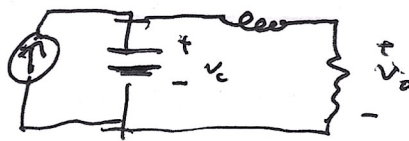


$$H(j\omega) = \frac{1}{1 + j\omega RC}$$

- Second order

$$H(s) = Z_{in}(s)$$

ω_c - corner freq of the zero.



- Filter characterization

- Analysis

- × Define $H(s)$
- × Convert to SSS $s = j\omega \Rightarrow H(j\omega)$
- × Construct Mag. Eq. $|H(j\omega)|$

- Steps

- × Specify type: High, Low, band-pass
- × Construct transfer func.
- × Design circuit.

Butterworth LPF

- Transfer function

$$|H(j\omega)| = \frac{|K|}{\sqrt{1 + \left(\frac{\omega}{\omega_c}\right)^{2n}}}$$

$\omega_c = \omega_{3dB}$ - corner freq

n - filter order

K - constant

- Normalized BLPF Transfer functions. ($K=1, \omega_c=1 \text{ rad/s}$)

$n=1 \quad H(s) = \frac{1}{s+1}$

$n=2 \quad H(s) = \frac{1}{s^2 + \sqrt{2}s + 1}$

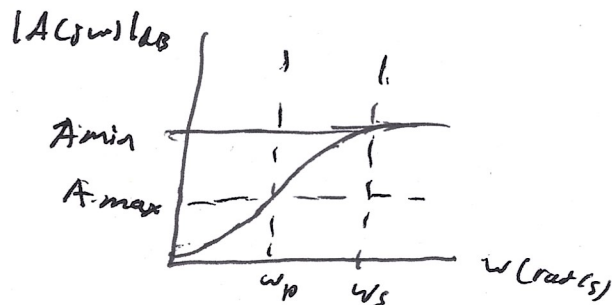
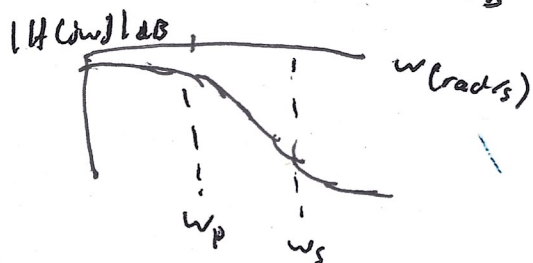
$n=3 \quad H(s) = \frac{1}{s^3 + 2s^2 + 2s + 1}$

$|A(j\omega)|_{dB} = -|H(j\omega)|_{dB}^{-1}$

$A(j\omega)_{dB} = -H(j\omega)_{dB}$

ω_p - pass band

ω_s - stop band



- Filter Design Steps. Design Specifications:

- Find filter order - $\left(\frac{\omega_s}{\omega_p}\right)^{2n} \geq \frac{10^{0.1A_{min}} - 1}{10^{0.1A_{max}} - 1}$
- Select transfer function
- select circuit structure
- Find + adjust ω_c if $A_{max} \neq 3dB$ ($\omega_c = \omega_p$ if $A_{max} = 3dB$)
- Magnitude + freq. scale as needed

$$\left\{ \begin{array}{l} A_{max}, A_{min} \\ \omega_p, \omega_s \end{array} \right\}$$

1. $n_{min} \geq \frac{\log \left(\frac{10^{0.1A_{min}} - 1}{10^{0.1A_{max}} - 1} \right)}{2 \log \left(\frac{\omega_s}{\omega_p} \right)}$

(select first int min)



- Choose transfer from normalized options

- If source R_s is known, add $1/R_s$ in series w/ filter and use mag scaling
- If load R_L is known, add $1/R_L$ in parallel w/ filter

- ω_c is half power freq.,

$$\frac{\omega_p}{(10^{0.1A_{max}} - 1)^{\frac{1}{2n}}} \leq \omega_c \leq \frac{\omega_s}{(10^{0.1A_{min}} - 1)^{\frac{1}{2n}}}$$

Butterworth HPF

• HPF Design

- Convert HPF to LPF
- Design Butterworth LPF
- Convert LPF to HPF
 - X C to L and L to C
 - X freq + mag scaling.

$$\begin{array}{ll}
 1. & \begin{array}{l} \omega < \omega_p \quad A < A_{\max} \\ \omega > \omega_s \quad A < A_{\min} \end{array} \Rightarrow \begin{array}{l} \omega < \omega_s \quad A > A_{\min} \\ \omega > \omega_p \quad A < A_{\max} \end{array}
 \end{array}$$

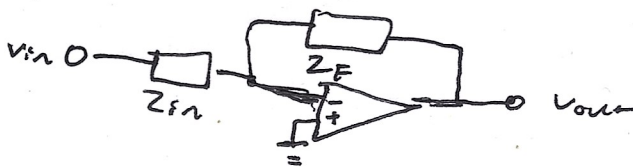
$$\Omega = \frac{\omega_p}{\omega}, \quad \Omega_p = \frac{\omega_p}{\omega_p} = 1, \quad \Omega_s = \frac{\omega_p}{\omega_s} > 1$$

2. Replace all ω_s w/ Ω_s .

$$\begin{array}{l}
 3. \quad \begin{array}{l} CLPF \rightarrow L_{HPF} = \frac{1}{CLPF} \\ L_{LPF} \rightarrow C_{HPF} = \frac{1}{L_{LPF}} \end{array}
 \end{array}$$

Active LPF

- Passive -
 - Requires Inductor ($> 2^{\text{nd}}$ order) which is most non-ideal element
 - Passband gain $< 0\text{dB}$ (other than peaking)
- Active
 - Can avoid Inductors
 - Pass band gain $> 0\text{dB}$
- Op-Amp LPFs



$$\Rightarrow H(s) = \frac{V_{out}}{V_{in}} = - \frac{Z_F(s)}{Z_{in}(s)}$$